

# A Hierarchical Approach to the Stochastic Analysis of Transmission Lines via Polynomial Chaos

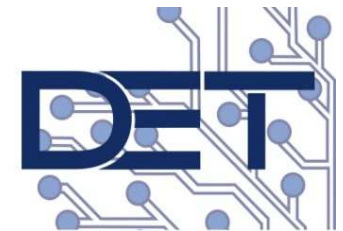
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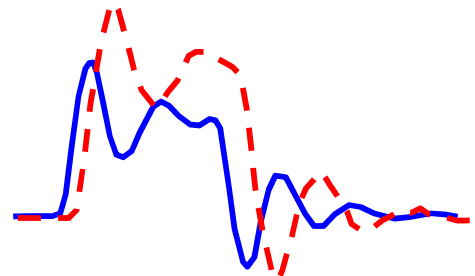
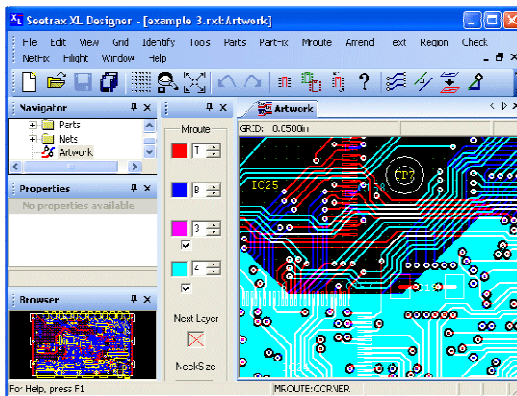
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# Manufacturing tolerances

- ❑ Predicted and measured responses can differ because of **manufacturing variability**, regardless of model accuracy

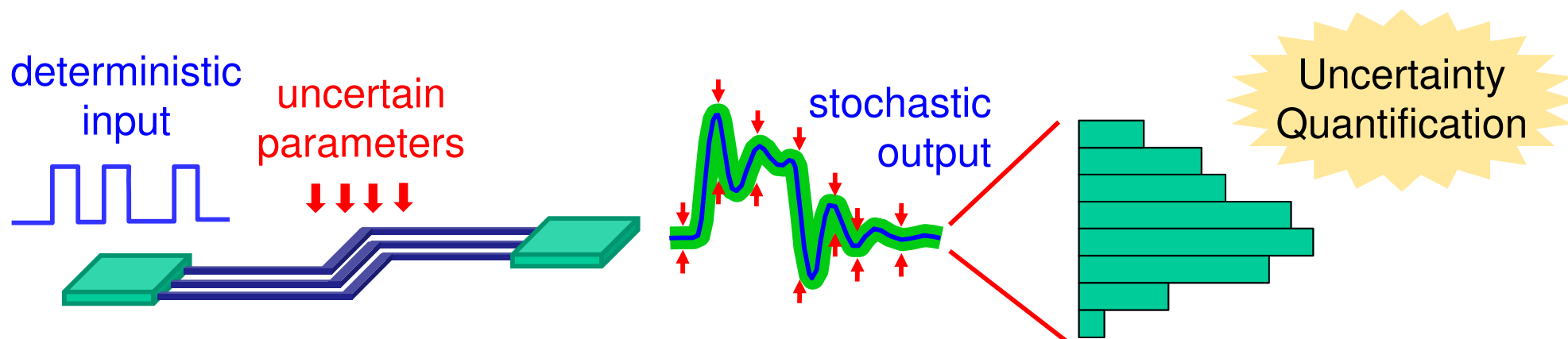


simulation



measurement

# Polynomial chaos expansion (PCE)



- Uncertain parameters are collectively denoted as  $\xi$
- Stochastic responses are modeled as expansions of polynomials **orthonormal** to the distribution of  $\xi$  [1]

$$v(t, \xi) \approx \sum_k v_k(t) \varphi_k(\xi)$$

deterministic coefficients

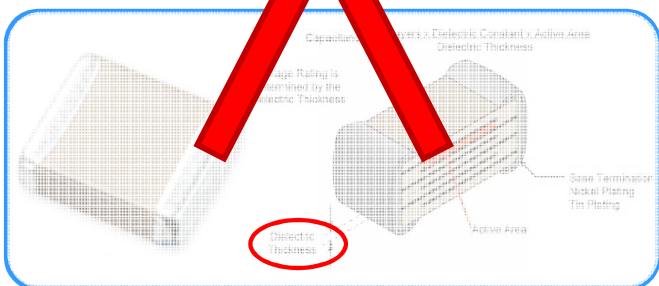
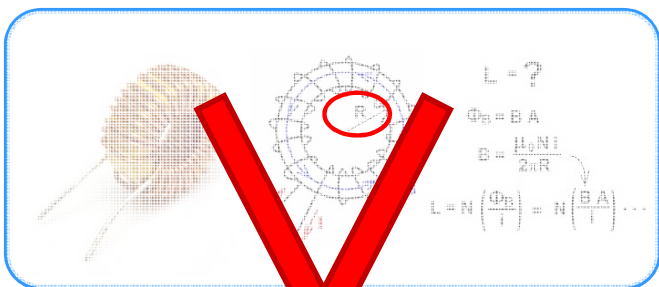
orthonormal polynomials

Calculation of PCE coefficients typically much faster than Monte Carlo

[1] P. Manfredi, D. Vande Ginste, I. S. Stievano, D. De Zutter, and F.G. Canavero, "Stochastic transmission line analysis via polynomial chaos methods: an overview," IEEE Electromagn. Compat. Mag. (2017).

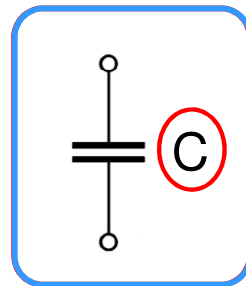
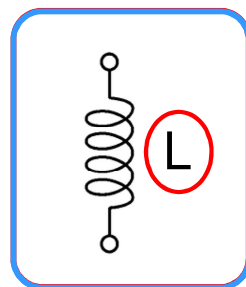
# Simulation flow for lumped circuits

Physical level



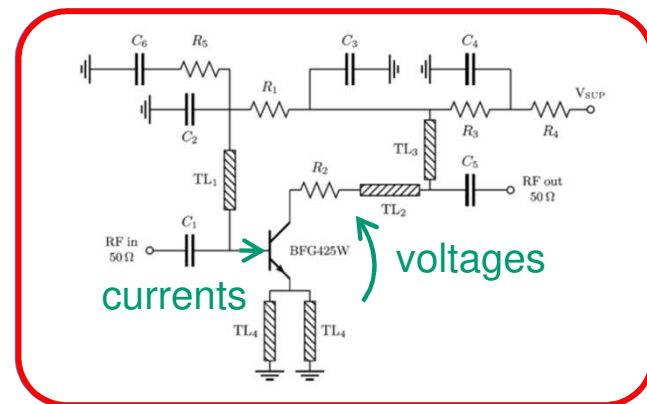
Geometry, materials  
Distribution:  
standard (e.g., Gaussian)

Component level



Component values  
Distribution: standard or  
non-standard (but still independent)

Electrical output level



PCE w.r.t.  
component values

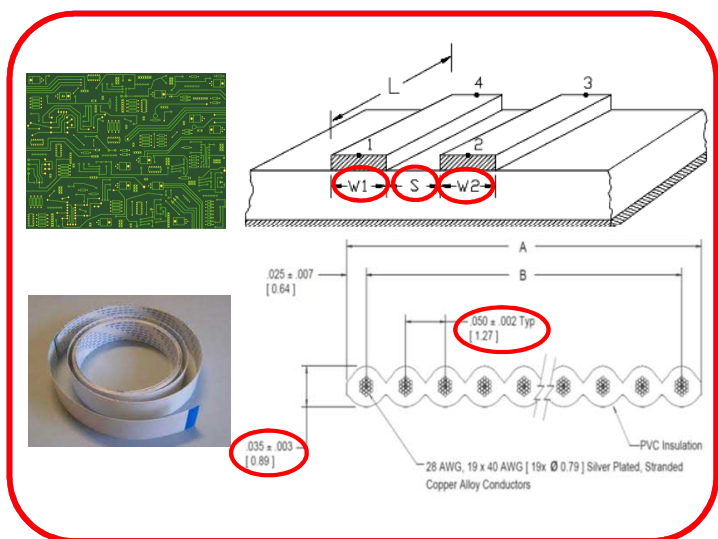
- ❑ Variability is usually modeled at **component level**

# Simulation flow for distributed transmission lines

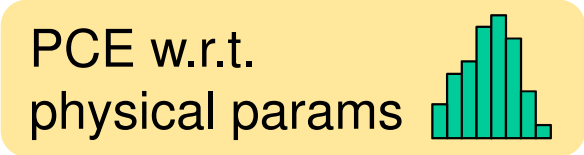
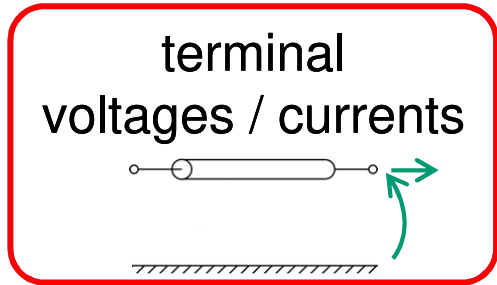
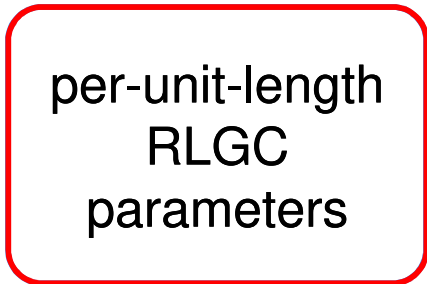
Physical (**low**) level

Component (**mid**) level

Electrical (**high**) output level



variability



- ❑ Variability is modeled at physical level because per-unit-length parameters are NOT independent!

Modeling at component level possible?



## Step #0: identification of random variables

- A **hierarchical approach** is implemented, in which the new random variables are (**mid-level**) entries of **per-unit-length matrices** [2]
- A different variable is assigned to each **distinct** entry:

$$\mathbf{L} = \begin{pmatrix} L_{11} & L_{12} & L_{13} \\ L_{21} & L_{22} & L_{23} \\ L_{31} & L_{32} & L_{33} \end{pmatrix} = \begin{pmatrix} & & \\ & & \\ & & \end{pmatrix}$$

reciprocity!

$$\mathbf{C} = \begin{pmatrix} C_{11} & C_{12} & C_{13} \\ C_{21} & C_{22} & C_{23} \\ C_{31} & C_{32} & C_{33} \end{pmatrix} = \begin{pmatrix} \eta_7 & \eta_8 & \eta_9 \\ \eta_8 & \eta_{10} & \eta_{11} \\ \eta_9 & \eta_{11} & \eta_{12} \end{pmatrix}$$

$\boldsymbol{\eta} = (\eta_1, \eta_2, \dots)$

- Other properties/assumptions (e.g., PEC planes, shields, homogeneity) may lead to further reduction in the number of mid-level parameters  $\boldsymbol{\eta}$

[2] P. Manfredi, "A hierarchical approach to dimensionality reduction and nonparametric problems in the polynomial chaos simulation of transmission lines," IEEE Trans. Electromagn. Compat. (early access)

## Advantages

1. **Dimensionality reduction** when per-unit-length (mid-level) parameters are fewer than physical (low-level) parameters

Cardinality:  $|\boldsymbol{\eta}| < |\boldsymbol{\xi}|$

2. Can deal with **nonparametric problems**, for which low-level parameters cannot be explicitly defined



3. Can achieve **higher accuracy** for a given expansion order

per-unit-length parameters  $\eta = f(\xi)$

$$v(\cancel{f(\xi)}) \approx \sum_k v_k \varphi_k(\xi) \quad \rightarrow \quad v(\boldsymbol{\eta}) \approx \sum_k \tilde{v}_k \tilde{\varphi}_k(\boldsymbol{\eta})$$

classical PCE hierarchical PCE



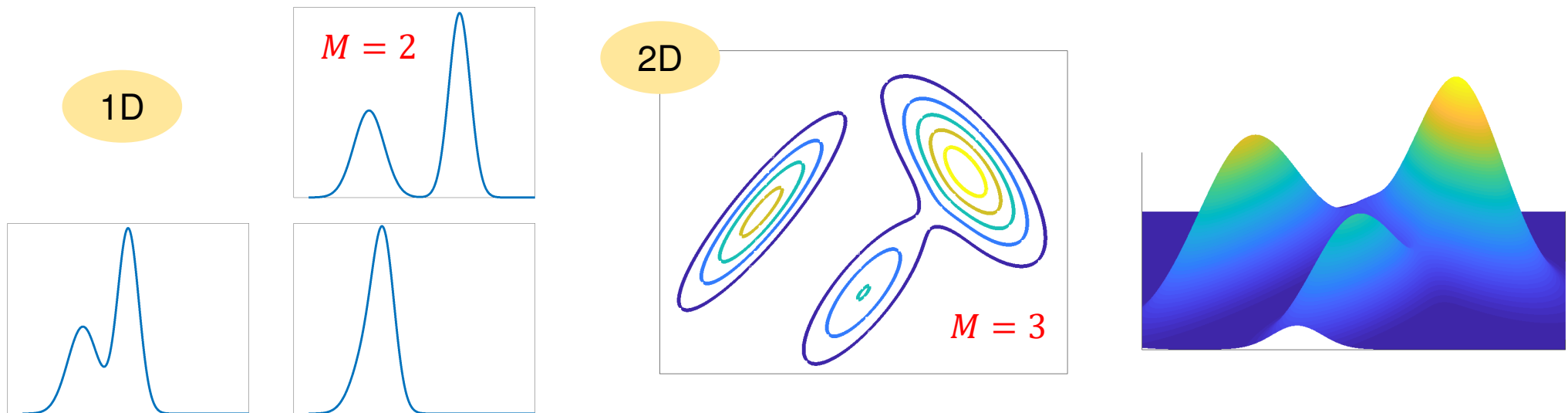
## Step #1: mixture of Gaussians (MoG) fit

- Empirical distribution of per-unit-length parameters (dependent entries  $\boldsymbol{\eta}$ ) is fitted using a **mixture of Gaussians (MoG)**
- A MoG is a **weighed combination** of **correlated** Gaussian distributions

$$\rho(\boldsymbol{\eta}) = \sum_{m=1}^M w_m \frac{e^{-\frac{1}{2}(\boldsymbol{\eta}-\boldsymbol{\mu}_m)^T \boldsymbol{\Sigma}_m^{-1} (\boldsymbol{\eta}-\boldsymbol{\mu}_m)}}{\sqrt{\det(2\pi \boldsymbol{\Sigma}_m)}}$$

weights  $w_m$ , means  $\boldsymbol{\mu}_m$ , covariance matrices  $\boldsymbol{\Sigma}_m$

analytical model





## Step #2: calculation of suitable basis functions

- ❑ Classical PCE uses standard polynomials (available a priori)
- ❑ Suitable basis function to be computed for **correlated** MoG distribution
- ❑ This is achieved through **Gram-Schmidt orthogonalization** [3]

previously-computed polynomials  
(iterative procedure)

Linearly  
independent  
monomials  $\{\Psi_k\}$



$$\hat{\varphi}_k = \Psi_k - \sum_{j=1}^{k-1} \underbrace{E\{\Psi_k \tilde{\varphi}_j\}}_{\text{orthogonalization}} \tilde{\varphi}_j$$

$$\tilde{\varphi}_k = \frac{\hat{\varphi}_k}{\sqrt{E\{\hat{\varphi}_k^2\}}} \quad (\text{normalization})$$

expectations = scalar coefficients  
(computed analytically or numerically)

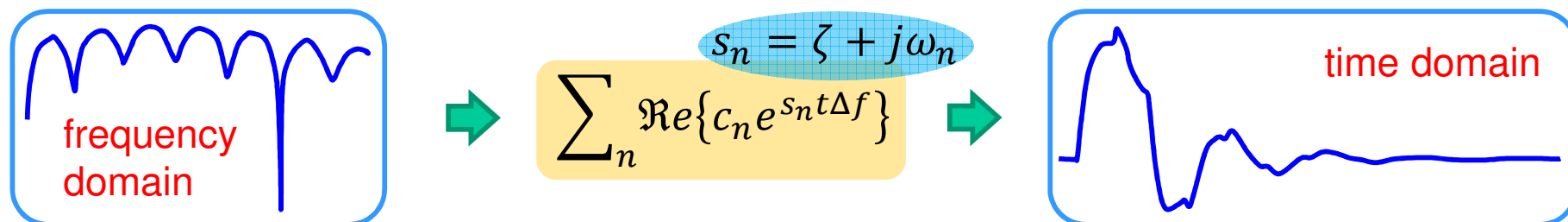
[3] C. Cui and Z. Zhang, "Stochastic collocation with non-Gaussian correlated process variations: theory, algorithms and applications," IEEE Trans. Compon. Packag. Manuf. Technol. (early access).

## Step #3: stochastic Galerkin method

- Voltage and current PCE coefficients are computed via stochastic Galerkin method [1]

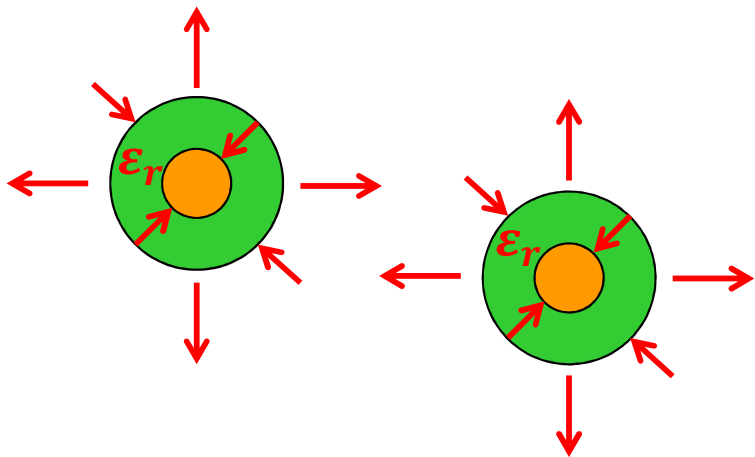


- To obtain transient results, the augmented transmission line can be:
  - ❖ Simulated directly into SPICE (lossless lines)
  - ❖ Solved in frequency domain and results post-processed with numerical inversion of Laplace transform (NILT) (lossy lines)



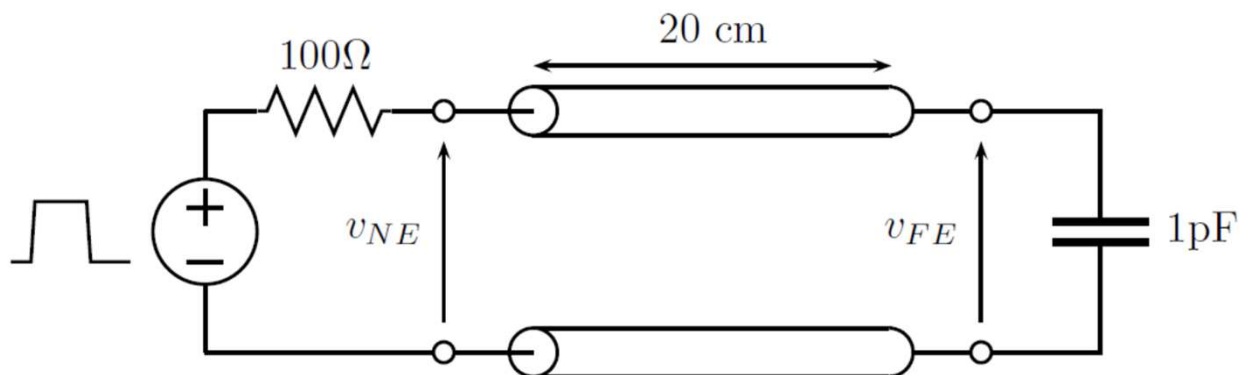
## Application #1: two wires

- Two wires with random position, geometry, and material properties [2]

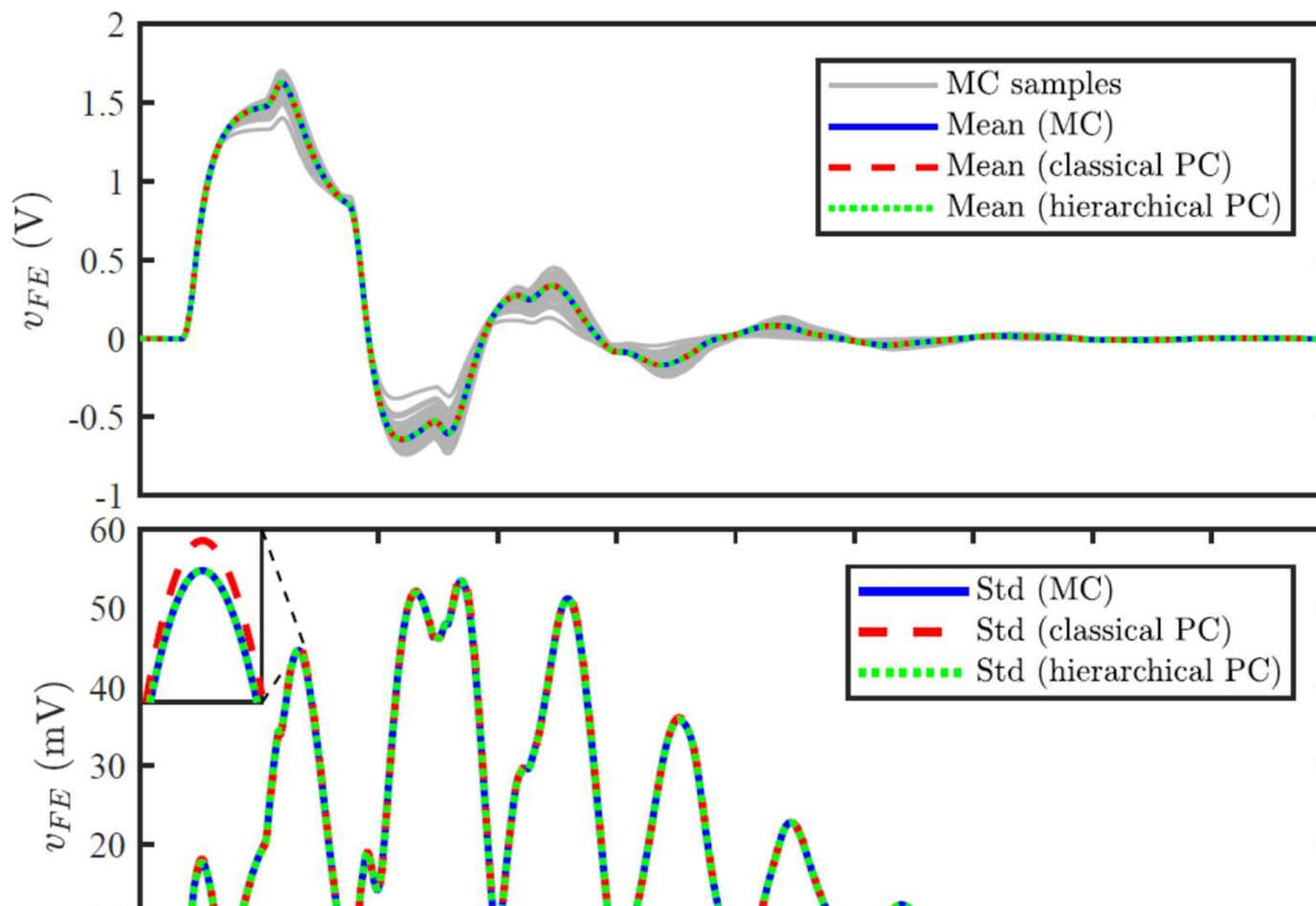


$\xi$  { low-level (physical):  
 4 coordinates (x-y) [constrained to avoid overlap]  
 4 geometrical (wire and dielectric radii)  
 2 material (dielectric permittivity)  
 TOTAL = 10

$\eta$  { mid-level (per-unit-length):  
 $L = \eta_1$   
 $C = \eta_2$   
 TOTAL = 2



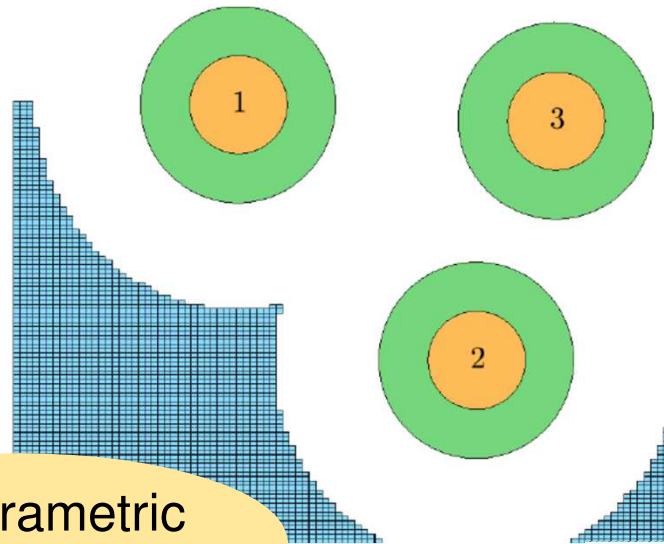
# Application #1: results



Empirical distribution of per-unit-length parameters	(all methods):	48.9 s	
Basis functions	(hierarchical PC):	22.6 s	
SPICE simulation	(Monte Carlo):	3490.0 s	
	(classical PC):	357.0 s	(9.8x)
	(hierarchical PC):	0.5 s	(7200x)

# Application #2: three wires above ground

- Three wires with completely random position (sequential placement) [2]

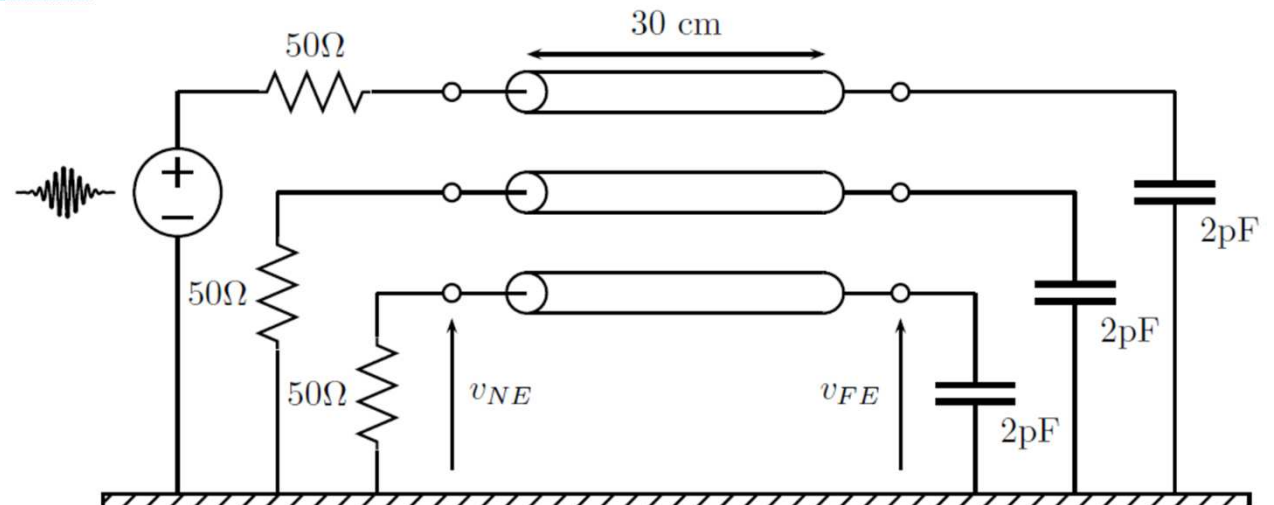


nonparametric problem!

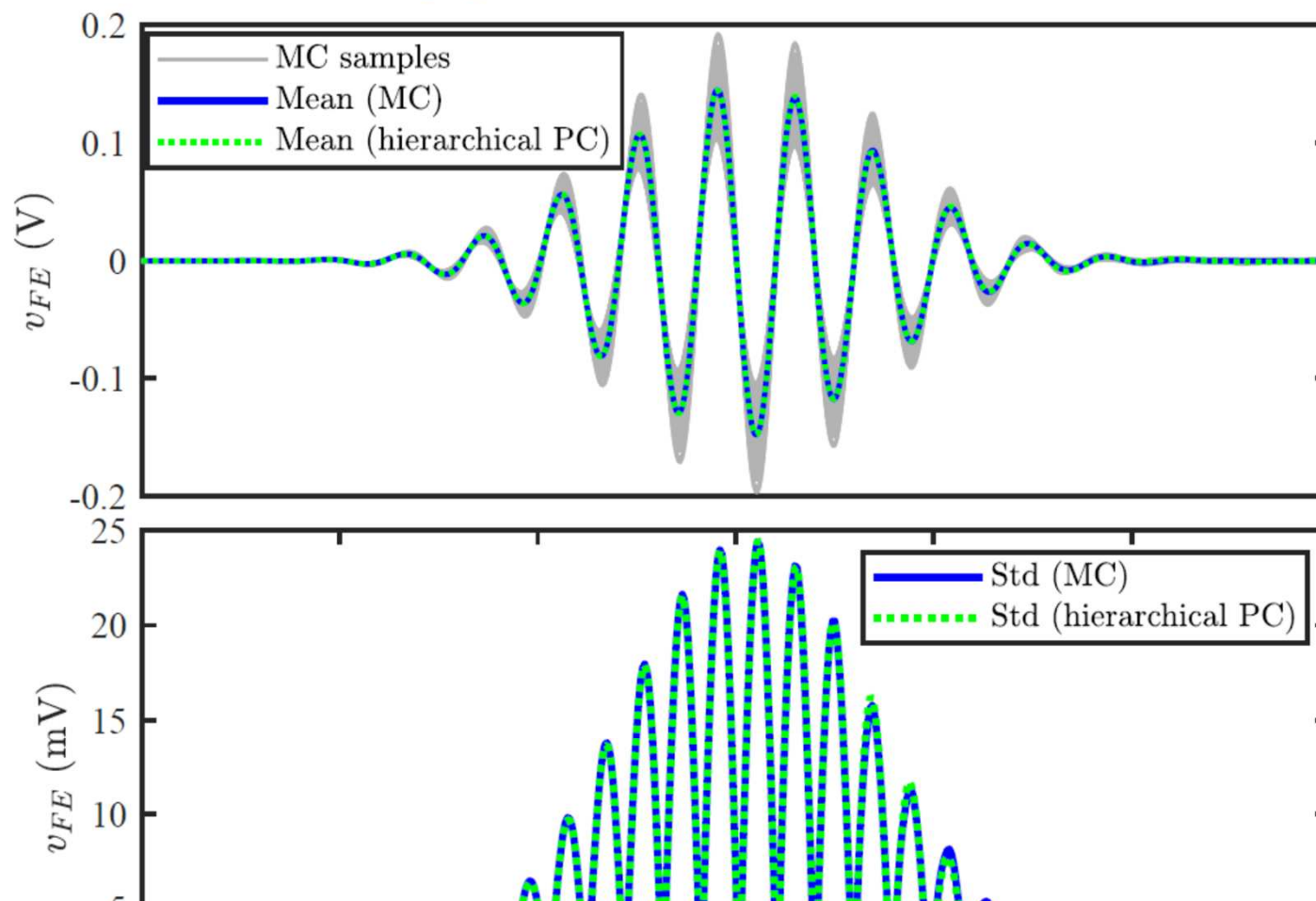
$\xi$  { low-level (physical):  
N/A

classical PCE N/A!

$\eta$  { mid-level (per-unit-length):  
6 per-unit-length inductance entries  
6 per-unit-length capacitance entries  
TOTAL = 12



## Application #2: results



Empirical distribution of per-unit-length parameters	(all methods):	226 s	
Basis functions	(hierarchical PC):	5 s	
SPICE simulation	(Monte Carlo):	4253 s	
	(classical PC):	N/A	
	(hierarchical PC):	23 s	(185x)

## Conclusions

- ❑ Novel **hierarchical approach** for stochastic analysis of transmission lines
- ❑ PCE-based modeling w.r.t. **mid-level** (per-unit-length) parameters
- ❑ Empirical distribution of per-unit-length parameters fitted using a **MoG**
- ❑ **Suitable basis functions** computed via **Gram-Schmidt orthogonalization**
- ❑ PCE coefficients of line response obtained with Galerkin-based simulation
- ❑ **Higher accuracy** for a given expansion order
- ❑ Possible **dimensionality reduction** ( $\Rightarrow$  **higher efficiency**)
- ❑ Handling of **nonparametric** problems (e.g., sequential wire placement)

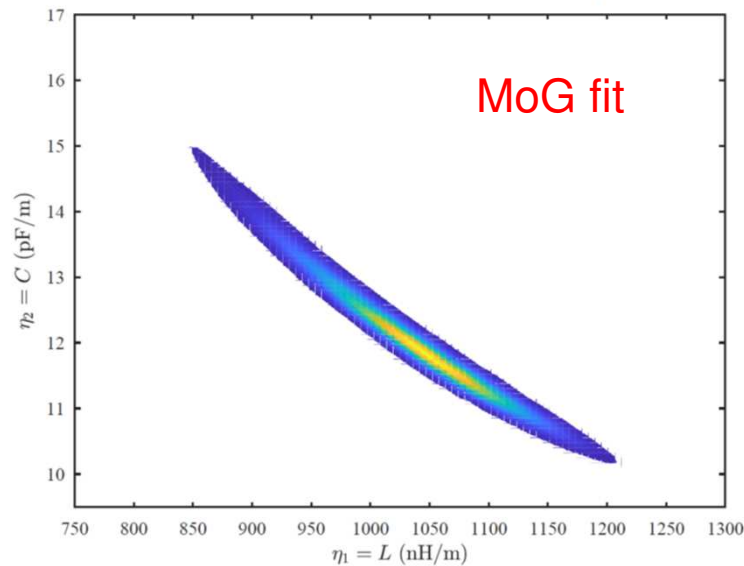
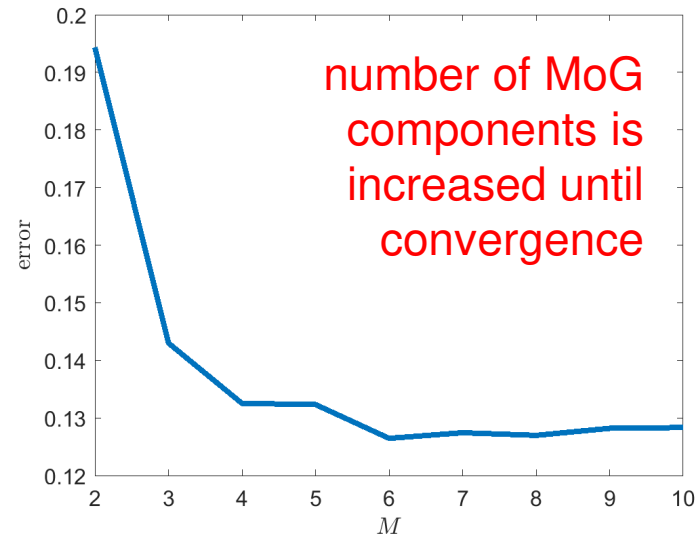
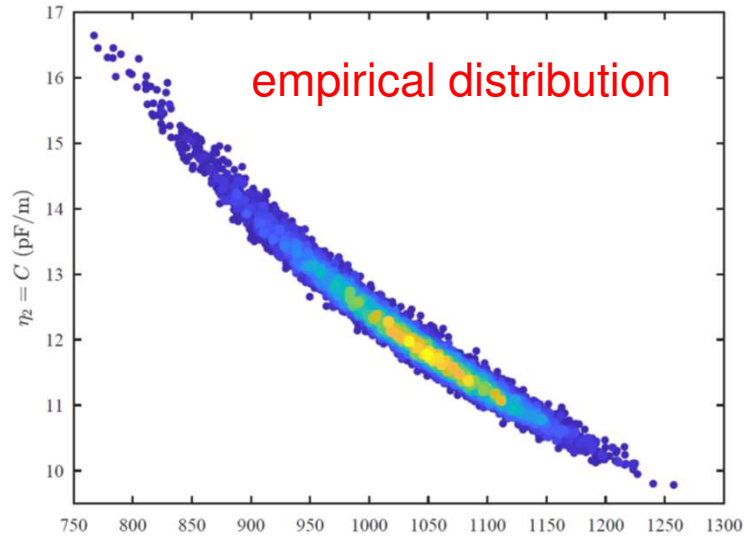


## References

- [1] P. Manfredi, D. Vande Ginste, I. S. Stievano, D. De Zutter, and F.G. Canavero, “Stochastic transmission line analysis via polynomial chaos methods: an overview,” *IEEE Electromagn. Compat. Mag.*, vol. 6, no. 3, pp. 77–84, 2017.
- [2] P. Manfredi, “A hierarchical approach to dimensionality reduction and nonparametric problems in the polynomial chaos simulation of transmission lines,” *IEEE Trans. Electromagn. Compat.* (early access).
- [3] C. Cui and Z. Zhang, “Stochastic collocation with non-Gaussian correlated process variations: theory, algorithms and applications,” *IEEE Trans. Compon. Packag. Manuf. Technol.* (early access).

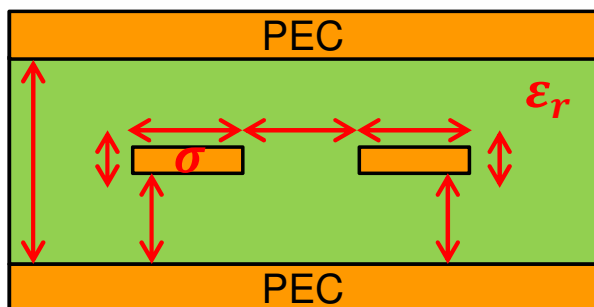
# Thank you for your attention!

# Application #1: MoG fit & polynomial basis



## Application #3: lossy stripline

- Stripline interconnect with frequency-dependent conductor losses



$$\mathbf{Z}(s, \xi) = \mathbf{R}_{dc}(\xi) + \sqrt{s/\pi} \mathbf{R}_{hf}(\xi) + s \mathbf{L}_{dc}(\xi)$$

SPICE model for frequency-dependent per-unit-length impedance matrix

$$\mathbf{R}_{dc} = \begin{pmatrix} \overset{\eta_1}{R_{11}} & \overset{\text{PEC ground}}{0} \\ \underset{\text{reciprocity}}{0} & \underset{\eta_2}{R_{22}} \end{pmatrix}$$

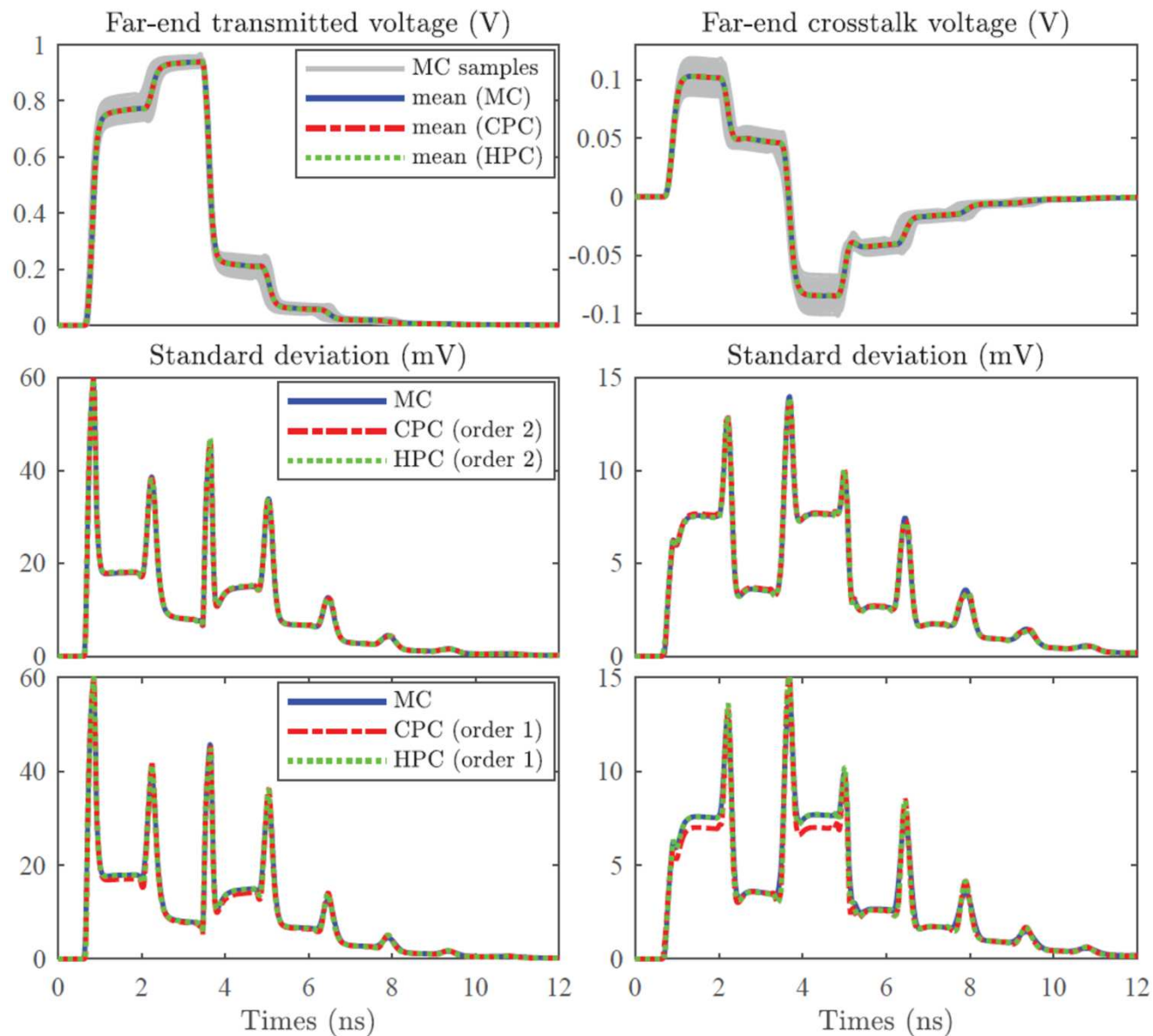
$$\mathbf{R}_{hf} = \begin{pmatrix} \overset{\eta_3}{R'_{11}} & \overset{\eta_4}{R'_m} \\ \underset{\text{reciprocity}}{R'_m} & \underset{\eta_5}{R'_{22}} \end{pmatrix}$$

$$\mathbf{L}_{dc} = \begin{pmatrix} \overset{\eta_6}{L_{11}} & \overset{\eta_7}{L_m} \\ \underset{\eta_8}{L_m} & \underset{\eta_8}{L_{22}} \end{pmatrix}$$

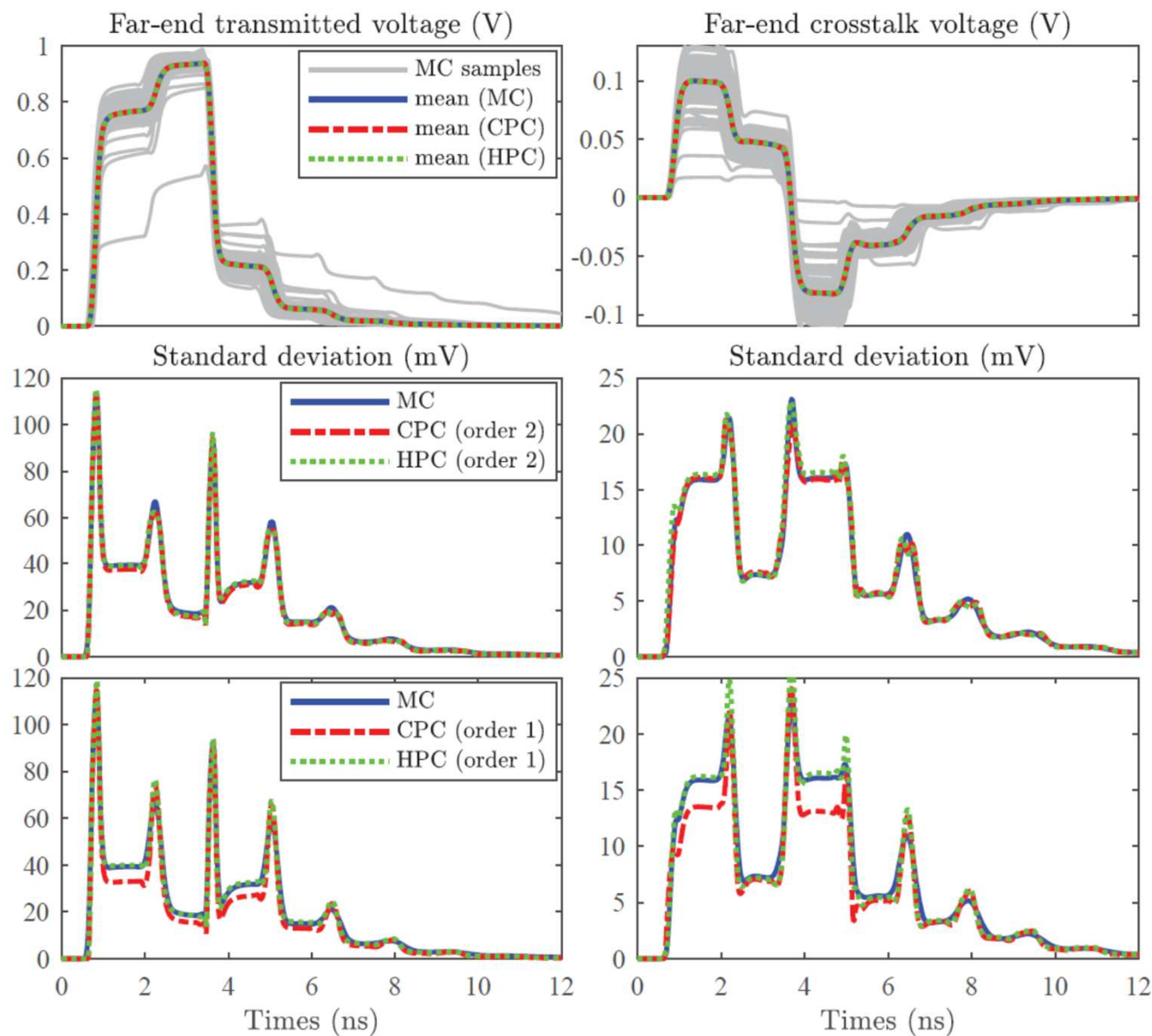
$$\mathbf{C}_{dc} = \underset{\eta_9}{\varepsilon_r \varepsilon_0 \mu_0} \mathbf{L}_{dc}^{-1}$$

Homogeneous structure  $\Rightarrow$  C-matrix has explicit dependence on  $\mathbf{L}_{dc}$ !

# Application #3: results (5% variation)



# Application #3: results (10% variation)



## Application #3: accuracy & efficiency

error definition: 
$$\mathcal{E} = \frac{1}{T} \int_0^T |\text{Std}_{\text{PC}}(t) - \text{Std}_{\text{MC}}(t)| dt$$

variation	quantity	order 1		order 2	
		CPC	HPC	CPC	HPC
5%	far-end transmission	2.9915e-04	1.9635e-04	8.6582e-05	8.1490e-05
	near-end crosstalk	4.1755e-04	2.4029e-04	1.2283e-04	1.1526e-04
	far-end crosstalk	2.6472e-04	1.3034e-04	6.7092e-05	5.9144e-05
10%	far-end transmission	9.3660e-04	5.8507e-04	3.5322e-04	4.4294e-04
	near-end crosstalk	2.6854e-03	1.1444e-03	9.2660e-04	6.8755e-04
	far-end crosstalk	1.0048e-03	4.6998e-04	2.8028e-04	3.7999e-04

Basis functions	(hierarchical PC, order 1):	3.2 s	
Augmented matrices	(classical PC, order 2):	49.7 s	
	(hierarchical PC, order 1):	0.3 s	(165x)
SPICE simulation	(classical PC, order 2):	57.2 s	
	(hierarchical PC, order 1):	2.4 s	(24x)